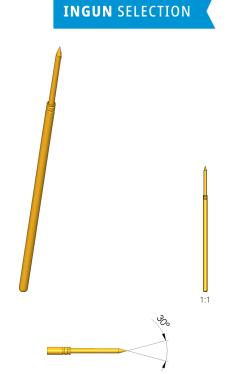
GKS-075 201 064 A 2000

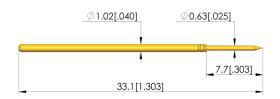
Item GKS-075-0022





- Well-established test probes for contacting PCBs
- For optimal contact to the test points (e.g. pads, vias, and pins), various tip styles with various diameters and finishes are available.
- · Various spring forces available as well as versions with stainless steel springs suitable for high temperatures
- Used for setting the optimum stroke conditions in the test fixture, various installation heights can be achieved by combining test probes and receptacles







ICT / FCT (in-circuit test and function test Product group: Sub-product group: Series: Grid: Contacting from: Magnetic: Installation type: Quick-exchange system:

Adjustable installation height: Non-rotating: Compatible receptacle(s): Min. temperature:

Max. temperature: RoHS-compliant:

Standard stroke test probe GKS-075 1.91 mm [75.1 mil]

Pad Yes Plug-in Yes No No

KS-075 -40 °C [-40 °F] 80 °C [176 °F]

Yes

Tip style data Tip style: 01 30° needle tip, self-cleaning Tip diameter: 0.64 mm [.025 in] Tip style surface: A gold Tip style material: 2 steel

Electrical data

Current load capacity / rated current: 3 A Typical resistance (Ri): 20 mOhm

Mechanical data

Recommended working stroke:

Total length: 33.1 mm [1.3 in] Barrel diameter: 1.02 mm [.04 in] Maximum stroke: 6.35 mm [.25 in] Spring pre-load: 0.72 N [2.58 ozf] Collar height: Spring force at working stroke: 2 N [7.19 ozf]

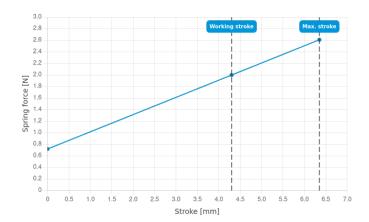
4.3 mm [.169 in]

Test Probe GKS-075 201 064 A 2000

Item GKS-075-0022







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Learn more about **ICT/FCT Test probes**

